

**SILICON EPITAXIAL PLANAR TRANSISTORS**

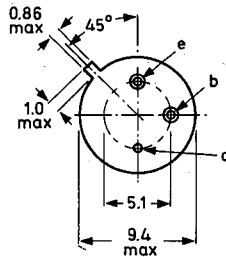
N-P-N transistors in a TO-39 metal envelope with the collector connected to the case. These transistors are intended for general purpose industrial applications.

**QUICK REFERENCE DATA**

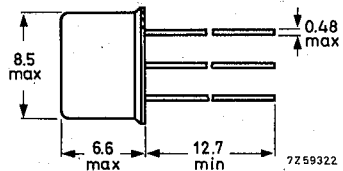
			BFY50	BFY51	BFY52	
Collector-base voltage (open emitter)	$V_{CBO}$	max.	80	60	40	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	35	30	20	V
Collector current (peak value)	$I_{CM}$	max.	1	1	1	A
Total dissipation up to $T_{mb} = 50\text{ }^{\circ}\text{C}$	$P_{tot}$	max.	5	5	5	W
Junction temperature	$T_j$	max.	200	200	200	$^{\circ}\text{C}$
D.C. current gain at $T_j = 25\text{ }^{\circ}\text{C}$ $I_C = 150\text{ mA}; V_{CE} = 10\text{ V}$	$h_{FE}$	typ.	112	123	142	
Transition frequency $I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$	$f_T$	typ.	140	160	185	MHz
Saturation voltage $I_C = 500\text{ mA}; I_B = 50\text{ mA}$	$V_{CESat}$	<	0.7	1.0	1.0	V

**MECHANICAL DATA**

TO-39  
Collector  
connected  
to case



Dimensions in mm



max. lead diameter is guaranteed only for 12.7 mm.  
Accessories supplied on request: 56218, 56245.

**RATINGS** Limiting values in accordance with the Absolute Maximum System (IEC 134)

Voltages

			BFY50	BFY51	BFY52	
Collector-base voltage (open emitter)	$V_{CBO}$	max.	80	60	40	V
Collector-emitter voltage (open base)	$V_{CEO}$	max.	35	30	20	V
Emitter-base voltage (open collector)	$V_{EBO}$	max.	6	6	6	V

Currents

Collector current (d. c.)	$I_C$	max.		1	A
Collector current (peak value)	$I_{CM}$	max.		1	A
Emitter current (d. c.)	$-I_E$	max.		1	A
Emitter current (peak value)	$-I_{EM}$	max.		1	A
Reverse base current (peak value)	$-I_{BM}$	max.		0.1	A

Power dissipation (See also page 8)

Total power dissipation up to $T_{mb} = 50\text{ }^\circ\text{C}$	$P_{tot}$	max.		5	W
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Temperatures

Storage temperature	$T_{stg}$			-65 to +200	$^\circ\text{C}$
Junction temperature	$T_j$	max.		200	$^\circ\text{C}$

**THERMAL RESISTANCE**

From junction to ambient in free air	$R_{th\ j-a}$	=		220	$^\circ\text{C}/\text{W}$
From junction to case	$R_{th\ j-c}$	=		35	$^\circ\text{C}/\text{W}$
From junction to mounting base	$R_{th\ j-mb}$	=		30	$^\circ\text{C}/\text{W}$

**CHARACTERISTICS**

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

<u>Collector cut-off current</u>		BFY50	BFY51	BFY52	
$I_E = 0; V_{CB} = 60\text{ V}$	$I_{CBO}$	typ.	2		nA
		<	50		nA
$I_E = 0; V_{CB} = 40\text{ V}$	$I_{CBO}$	typ.		2	nA
		<		50	nA
$I_E = 0; V_{CB} = 30\text{ V}$	$I_{CBO}$	typ.			2 nA
		<		50	nA
$I_E = 0; V_{CB} = 60\text{ V}; T_j = 100\text{ }^\circ\text{C}$	$I_{CBO}$	typ.	100		nA
		<	2.5		$\mu\text{A}$
$I_E = 0; V_{CB} = 40\text{ V}; T_j = 100\text{ }^\circ\text{C}$	$I_{CBO}$	typ.		100	nA
		<		2.5	$\mu\text{A}$
$I_E = 0; V_{CB} = 30\text{ V}; T_j = 100\text{ }^\circ\text{C}$	$I_{CBO}$	typ.			100 nA
		<		2.5	$\mu\text{A}$
<u>Emitter cut-off current</u>					
$I_C = 0; V_{EB} = 5\text{ V}$	$I_{EBO}$	typ.	2	2	2 nA
		<	50	50	50 nA
$I_C = 0; V_{EB} = 5\text{ V}; T_j = 100\text{ }^\circ\text{C}$	$I_{EBO}$	typ.	0.1	0.1	0.1 $\mu\text{A}$
		<	2.5	2.5	2.5 $\mu\text{A}$
<u>Saturation voltages</u>					
$I_C = 10\text{ mA}; I_B = 1.0\text{ mA}$	$V_{CEsat}$	typ.	0.06	0.06	0.06 V
		<	0.10	0.15	0.15 V
	$V_{BEsat}$	typ.	0.69	0.69	0.69 V
		<	1.2	1.2	1.2 V
$I_C = 150\text{ mA}; I_B = 15\text{ mA}$	$V_{CEsat}$	typ.	0.15	0.15	0.15 V
		<	0.20	0.35	0.35 V
	$V_{BEsat}$	typ.	0.92	0.92	0.92 V
		<	1.3	1.3	1.3 V
$I_C = 500\text{ mA}; I_B = 50\text{ mA}^1)$	$V_{CEsat}$	typ.	0.35	0.35	0.35 V
		<	0.70	1.00	1.00 V
	$V_{BEsat}$	typ.	1.15	1.15	1.15 V
		<	1.5	1.5	1.5 V
$I_C = 1\text{ A}; I_B = 100\text{ mA}^1)$	$V_{CEsat}$	typ.	0.66	0.66	0.66 V
		<	1.00	1.60	1.60 V
	$V_{BEsat}$	typ.	1.40	1.40	1.40 V
		<	2.0	2.0	2.0 V

<sup>1)</sup> Measured under pulsed conditions to avoid excessive dissipation.

## CHARACTERISTICS (continued)

$T_j = 25\text{ }^\circ\text{C}$  unless otherwise specified

### D.C. current gain

$I_C = 10\text{ mA}; V_{CE} = 10\text{ V}$

	BFY50	BFY51	BFY52
$h_{FE}$	> 20	30	30
	typ. 80	85	90

$I_C = 150\text{ mA}; V_{CE} = 10\text{ V}^{1)}$

$h_{FE}$	> 30	40	60
	typ. 112	123	142

$I_C = 500\text{ mA}; V_{CE} = 10\text{ V}^{1)}$

$h_{FE}$	> 20	25	30
	typ. 70	79	90

$I_C = 1\text{ A}; V_{CE} = 10\text{ V}^{1)}$

$h_{FE}$	> 15	15	15
	typ. 35	40	50

### Switching times (See also page 5)

$I_C = 150\text{ mA}; +I_B = -I_{BM} = 15\text{ mA}$

delay time

$t_d$	typ. 15	15	15	ns
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rise time

$t_r$	typ. 40	40	40	ns
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storage time

$t_s$	typ. 300	300	300	ns
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fall time

$t_f$	typ. 60	60	60	ns
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### Collector capacitance at $f = 1\text{ MHz}$

$I_E = I_e = 0; V_{CB} = 10\text{ V}$

$C_c$	< 12	12	12	pF
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### Transition frequency at $f = 35\text{ MHz}$

$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$

$f_T$	> 60	50	50	MHz
	typ. 140	160	185	MHz

### h parameters at $f = 1\text{ kHz}$

$I_C = 10\text{ mA}; V_{CE} = 5\text{ V}$

Input impedance

$h_{ie}$	< 750	750	750	$\Omega$
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Reverse voltage transfer ratio

$h_{re}$	< 5.0	5.0	5.0	$10^{-4}$
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Small signal current gain

$h_{fe}$	> 15	45	45
	typ. 90	100	110

Output admittance

$h_{oe}$	< 80	80	80	$\mu\Omega^{-1}$
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$I_C = 1\text{ mA}; V_{CE} = 5\text{ V}$

Small signal current gain

$h_{fe}$	> 10	30	30
	typ. 60	65	70

<sup>1)</sup> Measured under pulsed conditions to avoid excessive dissipation.

MEASUREMENT OF SWITCHING TIMES

Fig.1 : Circuit diagram

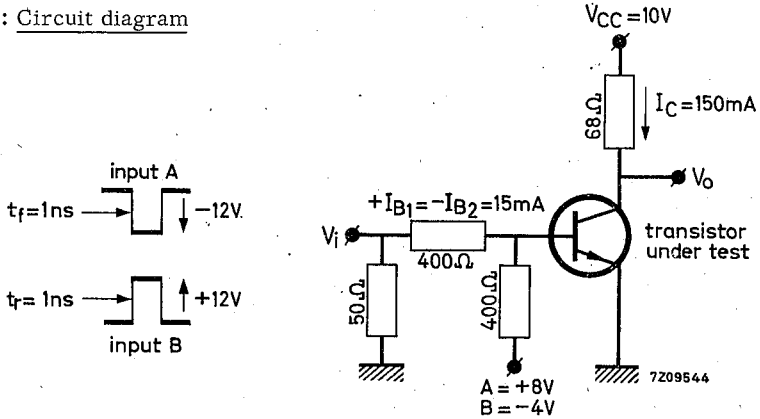
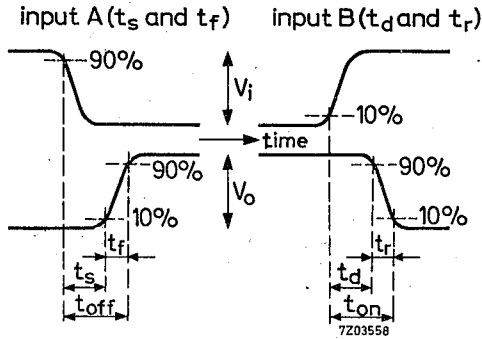


Fig.2 : Waveforms



Equipment Pulse generator: rise time  $t_r = 1 \text{ ns}$   
 pulse duration  $t_p = 1 \mu\text{s}$   
 Double beam or dual trace oscilloscope: rise time  $t_r < 5 \text{ ns}$